

## N-Channel Enhancement Mode MOSFET

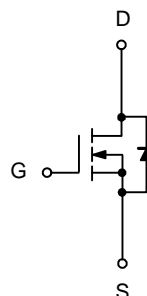
### Features

- 25V/60A ,  
 $R_{DS(ON)}=4.2m\Omega$  (typ.) @  $V_{GS}=10V$   
 $R_{DS(ON)}=6.5m\Omega$  (typ.) @  $V_{GS}=4.5V$
- Super High Dense Cell Design
- Avalanche Rated
- Reliable and Rugged
- Lead Free Available (RoHS Compliant)

### Pin Description



Top View of TO-220

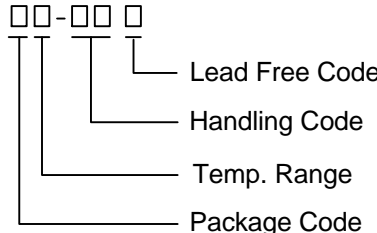



N-Channel MOSFET

### Applications

- Power Management in Computer or Switching Power Supply Systems

### Ordering and Marking Information

APM2506N		Package Code F : TO-220 Operating Junction Temp. Range C : -55 to 150°C Handling Code TU : Tube Lead Free Code L : Lead Free Device
APM2506N F :		XXXXX - Date Code

Note: ANPEC lead-free products contain molding compounds and 100% matte tin plate termination finish; which are fully compliant with RoHS and compatible with both SnPb and lead-free soldering operations. ANPEC lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J STD-020C for MSL classification at lead-free peak reflow temperature.

ANPEC reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

## Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
<b>Common Ratings</b> ( $T_A=25^\circ\text{C}$ Unless Otherwise Noted)				
$V_{DSS}$	Drain-Source Voltage	25	V	
$V_{GSS}$	Gate-Source Voltage	$\pm 20$		
$T_J$	Maximum Junction Temperature	150	$^\circ\text{C}$	
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ\text{C}$	
$I_S$	Diode Continuous Forward Current	$T_C=25^\circ\text{C}$ 30	A	
<b>Mounted on Large Heat Sink</b>				
$I_{DP}$	300 $\mu\text{s}$ Pulse Drain Current Tested	$T_C=25^\circ\text{C}$	240	A
		$T_C=100^\circ\text{C}$	220	
$I_D$	Continuous Drain Current	$T_C=25^\circ\text{C}$	60*	A
		$T_C=100^\circ\text{C}$	55	
$P_D$	Maximum Power Dissipation	$T_C=25^\circ\text{C}$	62.5	W
		$T_C=100^\circ\text{C}$	25	
$R_{\theta JC}$	Thermal Resistance-Junction to Case	2	$^\circ\text{C/W}$	
<b>Mounted on PCB of Minimum Footprint</b>				
$I_{DP}$	300 $\mu\text{s}$ Pulse Drain Current Tested	$T_A=25^\circ\text{C}$	60	A
		$T_A=100^\circ\text{C}$	35	
$I_D$	Continuous Drain Current	$T_A=25^\circ\text{C}$	15	A
		$T_A=100^\circ\text{C}$	9	
$P_D$	Maximum Power Dissipation	$T_A=25^\circ\text{C}$	2	W
		$T_A=100^\circ\text{C}$	0.8	
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	62.5	$^\circ\text{C/W}$	

Notes:

\* Current limited by bond wire.

## Electrical Characteristics ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Condition	APM2506NF			Unit
			Min.	Typ.	Max.	
<b>Drain-Source Avalanche Ratings</b>						
$E_{AS}$	Avalanche Energy, Single Pulsed	$I_{DS}=15\text{A}, V_{DD}=20\text{V}$			50	mJ
<b>Static Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_{DS}=250\mu\text{A}$	25			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=20\text{V}, V_{GS}=0\text{V}$ $T_J=85^\circ\text{C}$			1 30	$\mu\text{A}$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu\text{A}$	1.3	1.8	2.5	V
$I_{GSS}$	Gate Leakage Current	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$			$\pm 100$	nA
$R_{DS(ON)}^a$	Drain-Source On-state Resistance	$V_{GS}=10\text{V}, I_{DS}=40\text{A}$ $V_{GS}=4.5\text{V}, I_{DS}=20\text{A}$		4.2 6.5	5.5 8.5	$\text{m}\Omega$
<b>Diode Characteristics</b>						
$V_{SD}^a$	Diode Forward Voltage	$I_{SD}=10\text{A}, V_{GS}=0\text{V}$		0.7	1.1	V
$t_{rr}$	Reverse Recovery Time	$I_{DS}=10\text{A}, di_{SD}/dt=100\text{A}/\mu\text{s}$		30		ns
$Q_{rr}$	Reverse Recovery Charge			14		nC
<b>Dynamic Characteristics<sup>b</sup></b>						
$R_G$	Gate Resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, F=1\text{MHz}$		1.0	2.1	$\Omega$
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=15\text{V},$ Frequency=1.0MHz		3100		pF
$C_{oss}$	Output Capacitance			680		
$C_{riss}$	Reverse Transfer Capacitance			520		
$t_{d(ON)}$	Turn-on Delay Time	$V_{DD}=15\text{V}, R_L=15\Omega,$ $I_{DS}=1\text{A}, V_{GEN}=10\text{V},$ $R_G=6\Omega$		19		ns
$T_r$	Turn-on Rise Time			20		
$t_{d(OFF)}$	Turn-off Delay Time			62		
$T_f$	Turn-off Fall Time			43		
<b>Gate Charge Characteristics<sup>b</sup></b>						
$Q_g$	Total Gate Charge	$V_{DS}=15\text{V}, V_{GS}=4.5\text{V},$ $I_{DS}=40\text{A}$		37.5	56	nC
$Q_{gs}$	Gate-Source Charge			9.4		
$Q_{gd}$	Gate-Drain Charge			21		

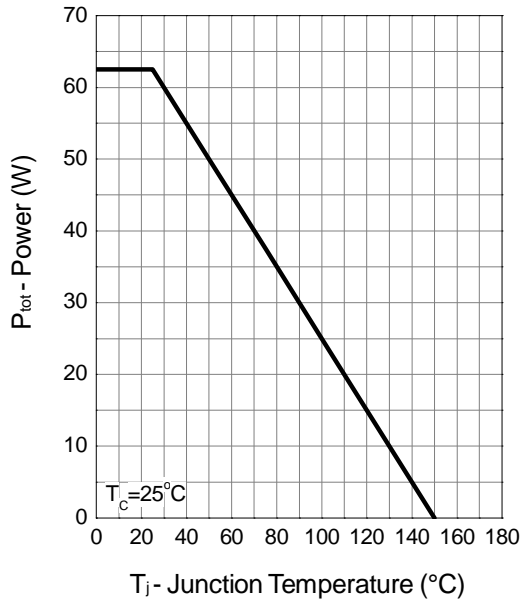
Notes:

a : Pulse test ; pulse width $\leq 300\mu\text{s}$ , duty cycle $\leq 2\%$ .

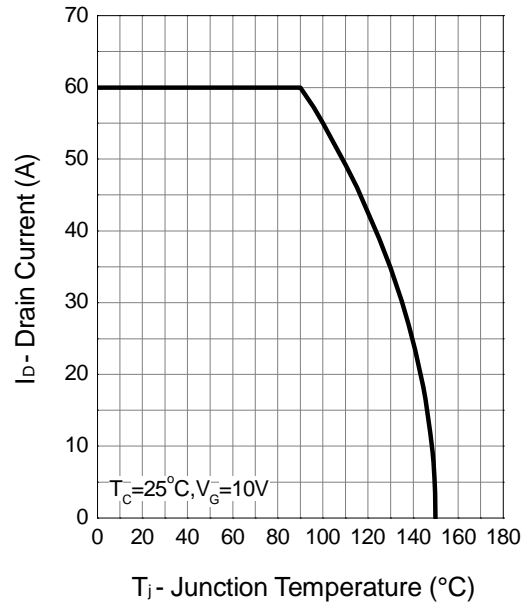
b : Guaranteed by design, not subject to production testing.

## Typical Characteristics

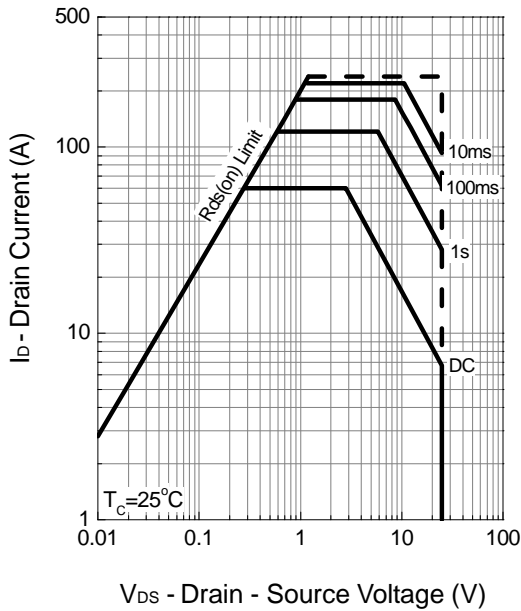
Power Dissipation



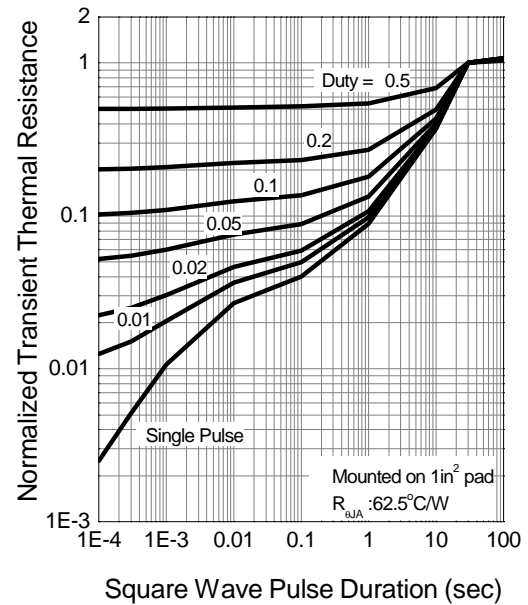
Drain Current



Safe Operation Area

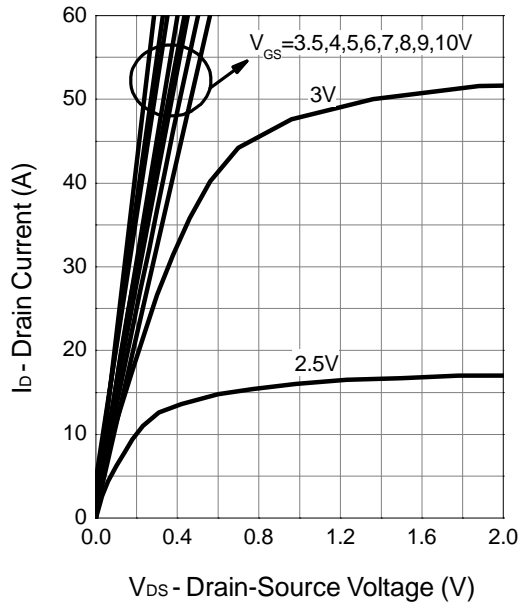


Thermal Transient Impedance

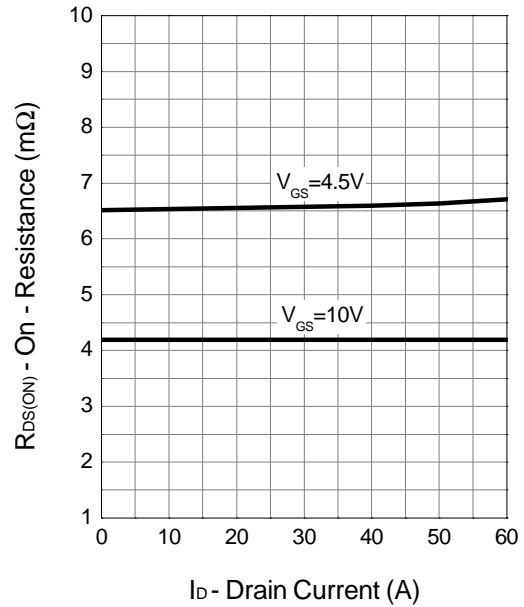


## Typical Characteristics (Cont.)

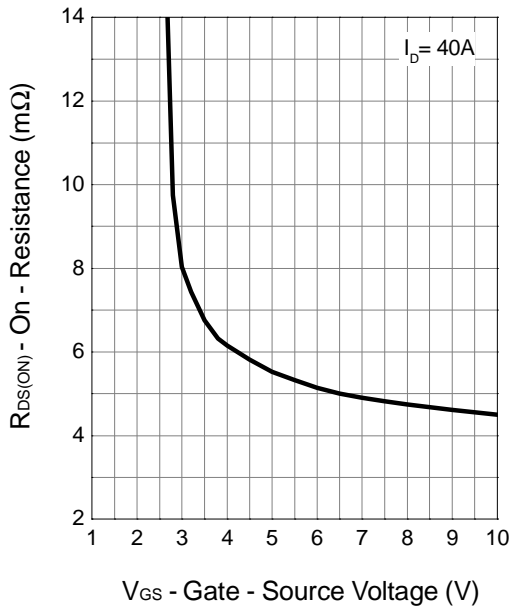
Output Characteristics



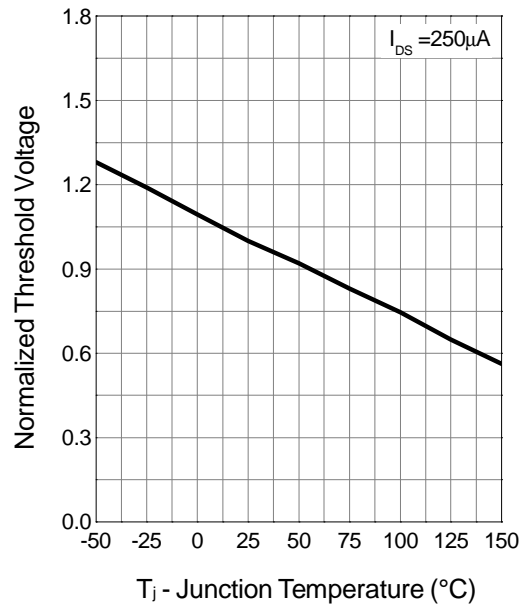
Drain-Source On Resistance



Gate-Source On Resistance

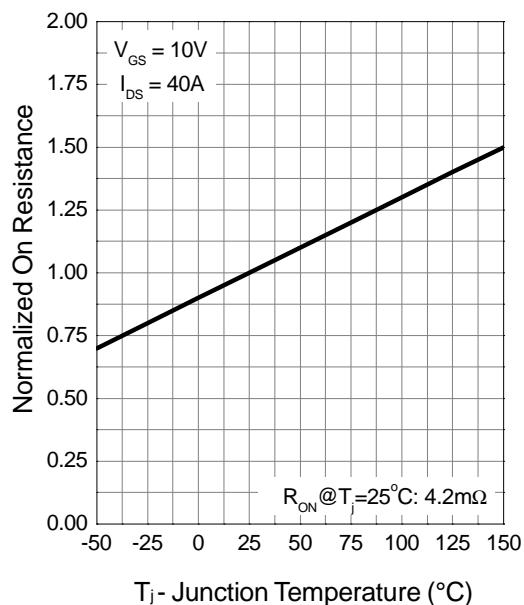


Gate Threshold Voltage

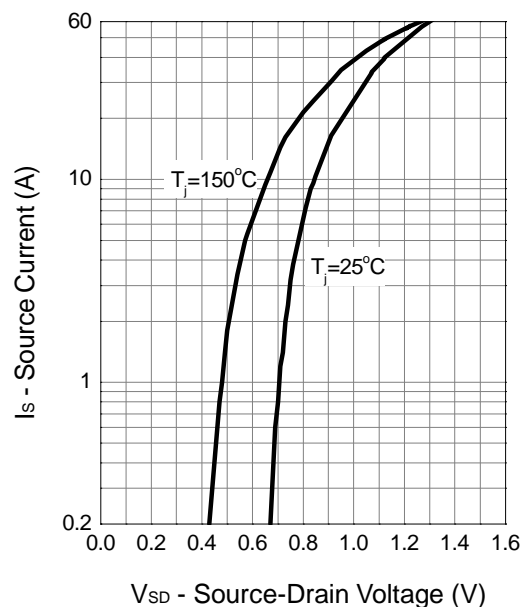


## Typical Characteristics (Cont.)

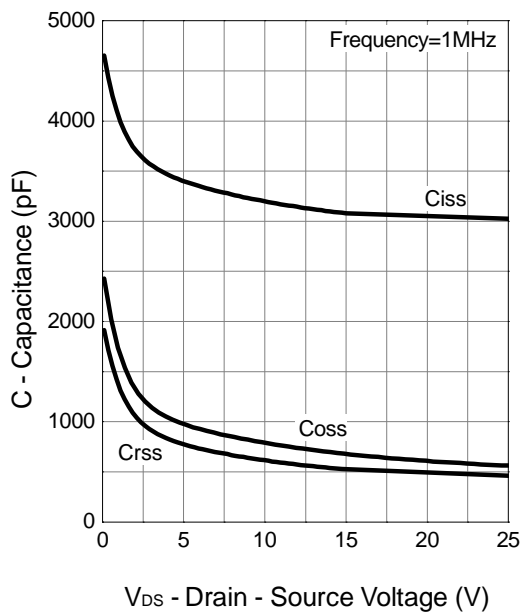
**Drain-Source On Resistance**



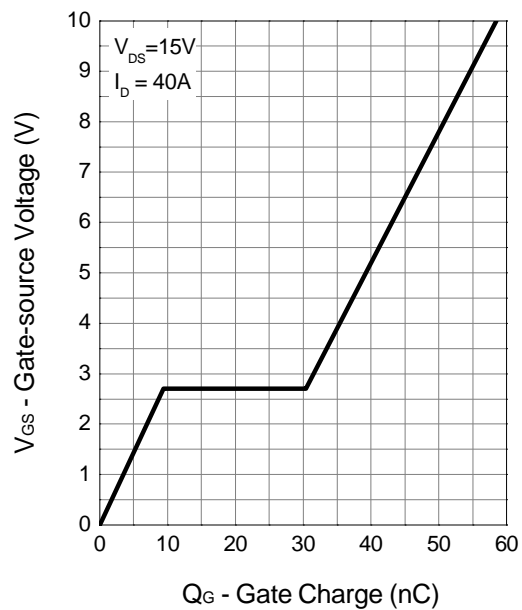
**Source-Drain Diode Forward**



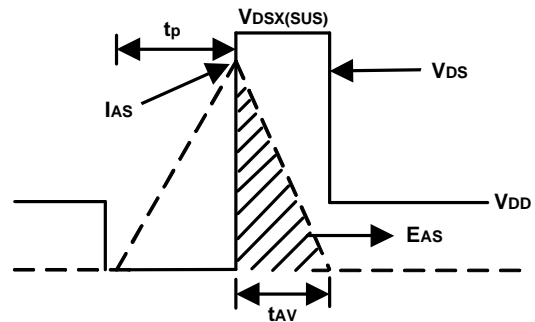
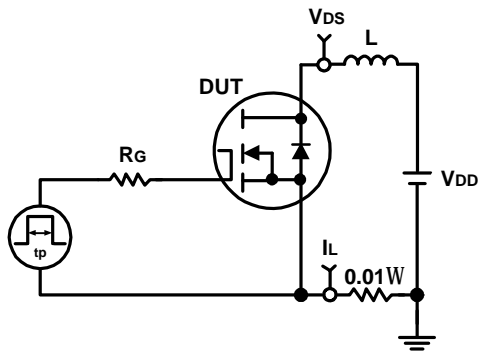
**Capacitance**



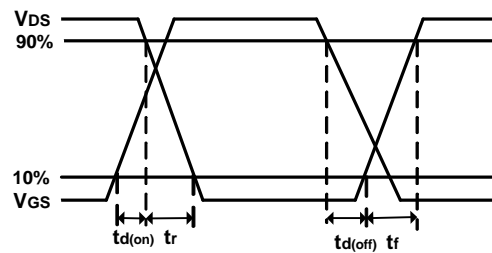
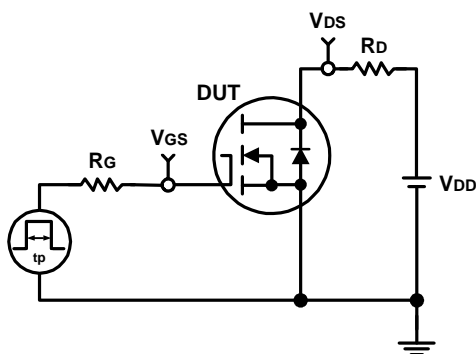
**Gate Charge**



## Avalanche Test Circuit and Waveforms

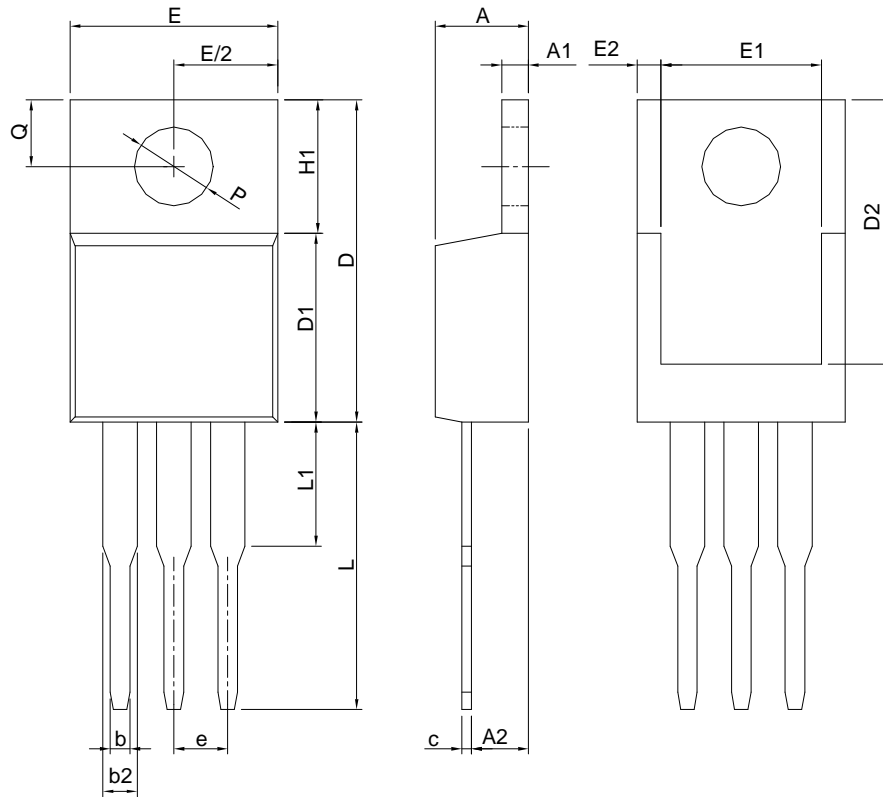


## Switching Time Test Circuit and Waveforms



## Package Information

TO-220



Dim	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	3.56	4.83	0.140	0.190
A1	0.51	1.40	0.020	0.055
A2	2.03	2.92	0.080	0.115
b	0.38	1.02	0.015	0.040
b2	1.14	1.78	0.045	0.070
c	0.36	0.61	0.014	0.024
D	14.22	16.51	0.560	0.650
D1	8.38	9.02	0.330	0.355
D2	12.19	12.88	0.480	0.507
E	9.65	10.67	0.380	0.420
E1	6.86	8.89	0.270	0.350
E2	-	0.76	-	0.030
e	2.54 BSC		0.100 BSC	
H1	5.84	6.86	0.230	0.270
L	12.70	14.73	0.500	0.580
L1	-	6.35	-	0.250
P	3.53	4.09	0.139	0.161
Q	2.54	3.43	0.100	0.135



## Physical Specifications

Terminal Material	Solder-Plated Copper (Solder Material : Sn)
Lead Solderability	Meets EIA Specification RSI86-91, ANSI/J-STD-002 Category 3.

## Reliability test program

Test item	Method	Description
SOLDERABILITY	MIL-STD-883D-2003	245°C,5 SEC
HOLT	MIL-STD 883D-1005.7	1000 Hrs Bias @125°C
PCT	JESD-22-B, A102	168 Hrs, 100% RH, 121°C
TST	MIL-STD 883D-1011.9	-65°C ~ 150°C, 200 Cycles

## Customer Service

### Anpec Electronics Corp.

Head Office :

No.6, Dusing 1st Road, SBIP,

Hsin-Chu, Taiwan, R.O.C.

Tel : 886-3-5642000

Fax : 886-3-5642050

Taipei Branch :

7F, No. 137, Lane 235, Pac Chiao Rd.,

Hsin Tien City, Taipei Hsien, Taiwan, R. O. C.

Tel : 886-2-89191368

Fax : 886-2-89191369